Search	Notes	

Application/Control No.	Applicant(s)/Patent und Reexamination	ter
10/750,971	TAKASHIMA ET AL.	
Examiner	Art Unit	
Brian P. Mruk	1751	·

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Class	Subclass	Date	Examiner
510	175, 176, 258, 273, 273, 413 41, 434,	2/1/06	Ban
Sio	481, 434, 435, 475	2/1/06	BPM
AS AROVE	T. DATE	8/17/06	Blm
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
West 2.0 Enclosed	DATE 2/1/06	BAN	
Palm Inventor Name Search	21/06	BAN	
As Above To Date	8/17/06	Blm	
AS ABOVE To DATE	3/8/07	BM	
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